

Product data sheet

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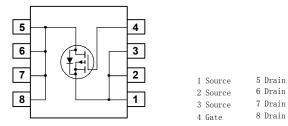


Features

- VDS (V) =-30V
- ID =-5.3 A (VGS =-10V)
- RDS(ON) < 50m Ω (VGS =-10V)
- $RDS(ON) < 80m \Omega$ (Vgs =-4.5V)
- Fast switching speed



SOP-8



Absolute Maximum Ratings Ta = 25° C

Parameter		Symbol	Rating	Unit	
Drain-Source Voltage		Vds	-30	V	
Gate-Source Voltage		Vgs	±20	v	
Continuous Drain Current		lo	-5.3	А	
Pulsed Drain Current		Ідм	-20	~	
	(Note.1) (Note.2) (Note.3)	PD	2.5		
Power Dissipation			1.2	W	
			1		
Thermal Resistance.Junction- to-Ambient		RthJA	50	°C/W	
Thermal Resistance.Junction- to-Case		RthJC	25		
Junction Temperature		TJ	150	Ċ	
Junction Storage Temperature Range		Tstg	-55 to 150	C	

Note.1: 50°C/W when mounted on a 1in $^{\scriptscriptstyle 2}$ pad of 2 oz copper

Note.2: 105°C/W when mounted on a .04 in² pad of 2 oz copper

Note.3: 125°C/W when mounted on a minimum pad.



■ Electrical Characteristics Ta = 25°C

Parameter	Symbol	Test Conditions		Тур	Max	Unit
Drain-Source Breakdown Voltage	VDSS	ID=-250 μ A, VGs=0V	-30			V
Zero Gate Voltage Drain Current	IDSS	VDS=-24V, VGS=0V			-1	μA
Gate-Body leakage current	lgss	VDS=0V, VGS=±20V			±100	nA
Gate Threshold Voltage	VGS(th)	VDS=VGS ID=-250 μ A	-1		-3	V
Static Drain-Source On-Resistance	RDS(ON)	VGS=-10V, ID=-5.3A (Note.1)			50	
		VGS=-10V, ID=-5.3A ,TJ=125°C (Note.1)			79	mΩ
		VGS=-4.5V, ID=-4.2A (Note.1)			80	
On state drain current	ID(ON)	VGS=-10V, VDS=-5V (Note.1)	-20			А
Forward Transconductance	gfs	VDS=-15V, ID=-5.3A (Note.1)		12		S
Input Capacitance	Ciss	Vgs=0V, Vds=-15V, f=1MHz		690		pF
Output Capacitance	Coss			306		
Reverse Transfer Capacitance	Crss			77		
Total Gate Charge	Qg	Vgs=-15V, Vds=-10V, Id=-5.3A		14	23	nC
Gate Source Charge	Qgs			2.4		
Gate Drain Charge	Qgd			4.8		
Turn-On DelayTime	td(on)	Vgs=-10V, Vds=-15V, Id=-1A,Rg=6 Ω		7	14	
Turn-On Rise Time	tr			10	18	ns
Turn-Off DelayTime	td(off)			19	34	
Turn-Off Fall Time	tr			11	20	
Maximum Body-Diode Continuous Current	ls				-5.3	А
Diode Forward Voltage	Vsd	Is=-5.3A,VGs=0V (Note.1)			-1.2	V

Note.1: Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%



MS9435 HF Compiance

■ Typical Characterisitics

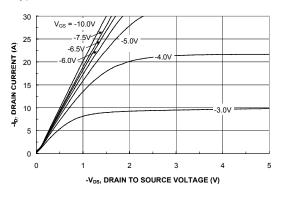


Figure 1. On-Region Characteristics.

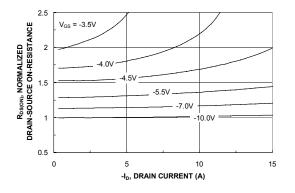


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

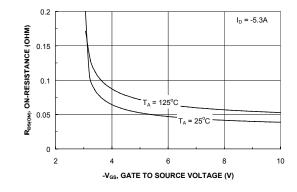


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

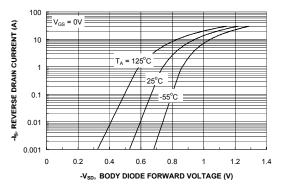


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

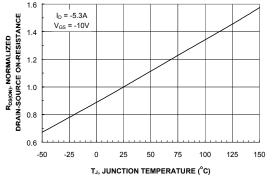


Figure 3. On-Resistance Variation with Temperature.

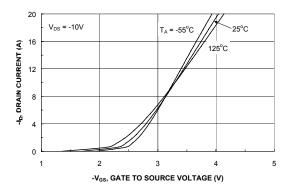


Figure 5. Transfer Characteristics.



MS9435 HF Compiance



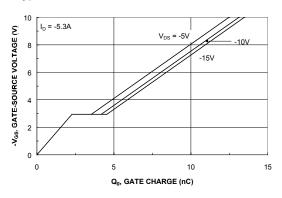


Figure 7. Gate Charge Characteristics.

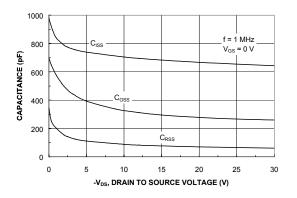


Figure 8. Capacitance Characteristics.

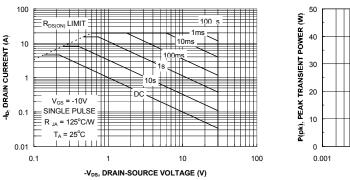
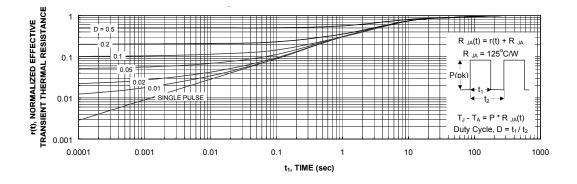


Figure 9. Maximum Safe Operating Area.

 $\frac{10}{100} \frac{100}{100} \frac{100}{100}{100} \frac{100}{100} \frac{100}{100}$

Figure 10. Single Pulse Maximum Power Dissipation.

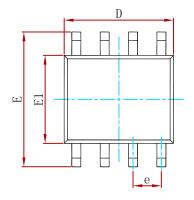


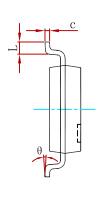


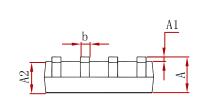




PACKAGE MECHANICAL DATA

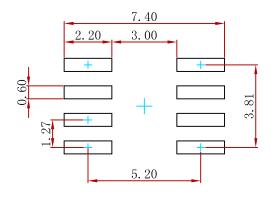






Symbol	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min	Max	Min	Max	
А	1.350	1.750	0.053	0.069	
A1	0.100	0.250	0.004	0.010	
A2	1.350	1.550	0.053	0.061	
b	0.330	0.510	0.013	0.020	
с	0.170	0.250	0.007	0.010	
D	4.800	5.000	0.189	0.197	
e	1.270 (BSC)	0.050	(BSC)	
E	5.800	6.200	0.228	0.244	
E1	3.800	4.000	0.150	0.157	
L	0.400	1.270	0.016	0.050	
θ	0 °	8°	0 °	8°	

Suggested Pad Layout



Note:

Controlling dimension:in millimeters.
General tolerance:± 0.05mm.
The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
MS9435	SOP-8	3000



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